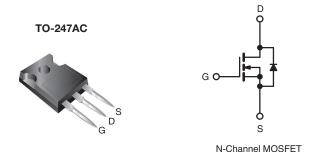


## Power MOSFET

| PRODUCT SUMMARY            |                            |  |  |  |  |
|----------------------------|----------------------------|--|--|--|--|
| V <sub>DS</sub> (V)        | 1000                       |  |  |  |  |
| $R_{DS(on)}(\Omega)$       | V <sub>GS</sub> = 10 V 2.0 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC) | 190                        |  |  |  |  |
| Q <sub>gs</sub> (nC)       | 23                         |  |  |  |  |
| Q <sub>gd</sub> (nC)       | 110                        |  |  |  |  |
| Configuration              | Single                     |  |  |  |  |



### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247AC for package preferred commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

| ORDERING INFORMATION |             |  |  |
|----------------------|-------------|--|--|
| Package              | TO-247AC    |  |  |
| Lead (Pb)-free       | IRFPG50PbF  |  |  |
| Leau (FD)-iree       | SiHFPG50-E3 |  |  |
| SnPb                 | IRFPG50     |  |  |
| SIFD                 | SiHFPG50    |  |  |

| PARAMETER   | SYMBOL                                | LIMIT           | UNIT             |          |  |
|---|---------------------------------------|-----------------|------------------|----------|--|
| Drain-Source Voltage                                  |                                       | V <sub>DS</sub> | 1000             | V        |  |
| Gate-Source Voltage                                   |                                       | $V_{GS}$        | ± 20             | 7 V      |  |
| Continuous Drain Current                              | $V_{GS}$ at 10 V $T_C = 25 ^{\circ}C$ | I-              | 6.1              |          |  |
| Continuous Drain Guirent                              | $T_C = 100 ^{\circ}C$                 | I <sub>D</sub>  | 3.9              | A        |  |
| Pulsed Drain Current <sup>a</sup>                     |                                       | I <sub>DM</sub> | 24               |          |  |
| Linear Derating Factor                                |                                       | 1.5             | W/°C             |          |  |
| Single Pulse Avalanche Energy <sup>b</sup>            | E <sub>AS</sub>                       | 800             | mJ               |          |  |
| Repetitive Avalanche Current <sup>a</sup>             | I <sub>AR</sub>                       | 6.0             | Α                |          |  |
| Repetitive Avalanche Energy <sup>a</sup>              |                                       | E <sub>AR</sub> | 19               | mJ       |  |
| Maximum Power Dissipation                             | $P_{D}$                               | 190             | W                |          |  |
| Peak Diode Recovery dV/dtc                            | dV/dt                                 | 1.0             | V/ns             |          |  |
| Operating Junction and Storage Temperature Range      | T <sub>J</sub> , T <sub>stg</sub>     | - 55 to + 150   | °C               |          |  |
| Soldering Recommendations (Peak Temperature) for 10 s |                                       |                 | 300 <sup>d</sup> |          |  |
| Manustine Tanana                                      | 6-32 or M3 screw                      |                 | 10               | lbf ⋅ in |  |
| Mounting Torque                                       | 0-32 OF IVIS SCIEW                    |                 | 1.1              | N⋅m      |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50~V$ , starting  $T_J=25~^{\circ}C$ , L=40~mH,  $R_g=25~\Omega$ ,  $I_{AS}=6.1~A$  (see fig. 12). c.  $I_{SD}\leq 6.1~A$ , dl/dt  $\leq 120~A/\mu s$ ,  $V_{DD}\leq 600$ ,  $T_J\leq 150~^{\circ}C$ . d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



| THERMAL RESISTANCE RATINGS          |                   |      |      |      |  |
|-------------------------------------|-------------------|------|------|------|--|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient         | R <sub>thJA</sub> | -    | 40   |      |  |
| Case-to-Sink, Flat, Greased Surface | R <sub>thCS</sub> | 0.24 | -    | °C/W |  |
| Maximum Junction-to-Case (Drain)    | R <sub>thJC</sub> | -    | 0.65 |      |  |

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS  |  | MIN.      | TYP.      | MAX.                 | UNIT             |
|---|-----------------------|--|--|-----------|-----------|----------------------|------------------|
| Static                                    |                       |  |  |           |           | l                    |                  |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>       | $V_{GS} = 0$   | V, I <sub>D</sub> = 250 μA   | 1000      | -         | -                    | V                |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_{J}$ | Reference  | to 25 °C, I <sub>D</sub> = 1 mA  | -         | 1.2       | -                    | V/°C             |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>   | $V_{DS} = V$   | ' <sub>GS</sub> , I <sub>D</sub> = 250 μA  | 2.0       | -         | 4.0                  | V                |
| Gate-Source Leakage                       | I <sub>GSS</sub>      | V <sub>G</sub>   | <sub>S</sub> = ± 20 V  | -         | -         | ± 100                | nA               |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>      |  | 000 V, V <sub>GS</sub> = 0 V   | -         | -         | 100                  | μА               |
| 20.0 date 10.1age 2.a 0ao                 | .033                  | $V_{DS} = 800 \text{ V}, \text{ V}$  | / <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                                     | -         | -         | 500                  | μΑ               |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V   | $I_D = 3.6 A^b$  | -         | -         | 2.0                  | Ω                |
| Forward Transconductance                  | 9fs                   | $V_{DS} = 10$  | 00 V, I <sub>D</sub> = 3.6 A <sup>b</sup>  | 5.4       | -         | -                    | S                |
| Dynamic                                   |                       |  |  |           |           |                      |                  |
| Input Capacitance                         | $C_{iss}$             | V  | $t_{GS} = 0 \text{ V},$  | -         | 2800      | -                    |                  |
| Output Capacitance                        | C <sub>oss</sub>      | V  | os = 25 V,   | -         | 250       | -                    | pF               |
| Reverse Transfer Capacitance              | $C_{rss}$             | f = 1.0 MHz, see fig. 5  |  | -         | 84        | -                    |                  |
| Total Gate Charge                         | Qg                    |  |  | -         | -         | 190                  | nC               |
| Gate-Source Charge                        | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V   | $I_D = 6.1 \text{ A}, V_{DS} = 400 \text{ V},$<br>see fig. 6 and 13 <sup>b</sup>   | -         | -         | 23                   |                  |
| Gate-Drain Charge                         | Q <sub>gd</sub>       | see lig. 6 and 15  |  | -         | -         | 110                  |                  |
| Turn-On Delay Time                        | t <sub>d(on)</sub>    | $V_{DD} = 500 \text{ V, } I_D = 6.1 \text{ A,}$ $R_g = 6.2 \ \Omega, \ R_D = 81 \ \Omega, \ \text{see fig. } 10^b$ |  | -         | 19        | -                    | ns               |
| Rise Time                                 | t <sub>r</sub>        |  |  | -         | 35        | -                    |                  |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>   |  |  | -         | 130       | -                    |                  |
| Fall Time                                 | t <sub>f</sub>        |  |  | -         | 36        | -                    |                  |
| Internal Drain Inductance                 | L <sub>D</sub>        | Between lead,<br>6 mm (0.25") from   |  | -         | 5.0       | -                    | -11              |
| Internal Source Inductance                | L <sub>S</sub>        | package and ce<br>die contact  | package and center of  |           | 13        | -                    | - nH             |
| Drain-Source Body Diode Characteristic    | s                     | ·  |  |           |           |                      |                  |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p - n junction diode  |  | -         | -         | 6.1                  | A                |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>       |  |  | -         | -         | 24                   |                  |
| Body Diode Voltage                        | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C, I <sub>5</sub>   | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 6.1 A, V <sub>GS</sub> = 0 V <sup>b</sup> |           | -         | 1.8                  | V                |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>       | T 05 °C 1  | C 1 A d1/d+ 100 A/b  | -         | 630       | 950                  | ns               |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>       | $T_J = 25  ^{\circ}\text{C}, I_F = 6.1  \text{A},  \text{dI/dt} = 100  \text{A/}\mu\text{s}^b$                     |  | -         | 3.5       | 5.3                  | μC               |
| Forward Turn-On Time                      | t <sub>on</sub>       | Intrinsic turn   | -on time is negligible (turn   | on is dor | minated b | y L <sub>S</sub> and | L <sub>D</sub> ) |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

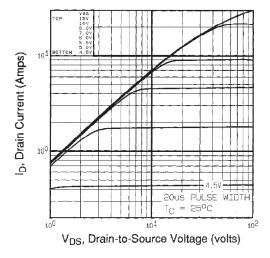


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

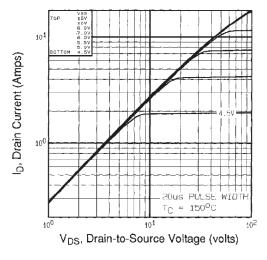
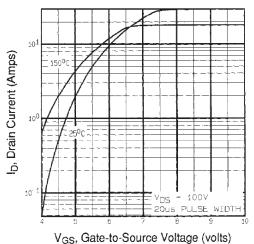


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C



VGS, date to bourse voltage (volta)

Fig. 3 - Typical Transfer Characteristics

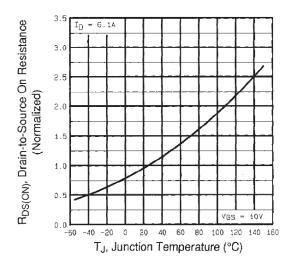


Fig. 4 - Normalized On-Resistance vs. Temperature



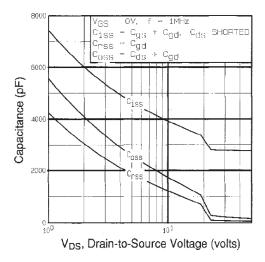


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

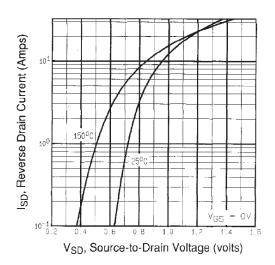


Fig. 7 - Typical Source-Drain Diode Forward Voltage

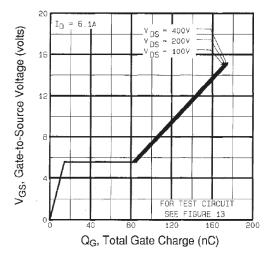


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

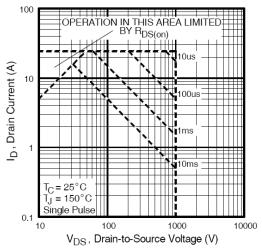


Fig. 8 - Maximum Safe Operating Area





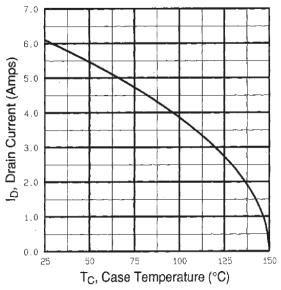


Fig. 9 - Maximum Drain Current vs. Case Temperature

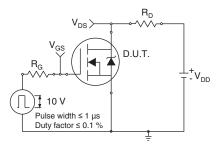


Fig. 10a - Switching Time Test Circuit

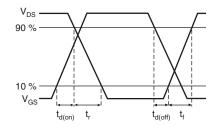


Fig. 10b - Switching Time Waveforms

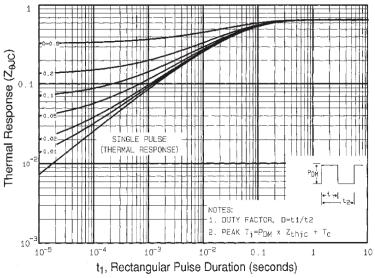
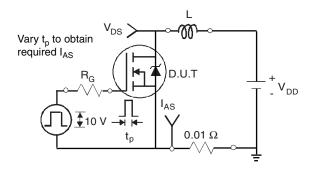


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





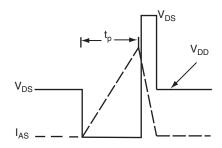


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

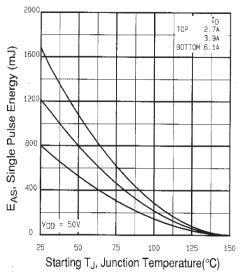


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

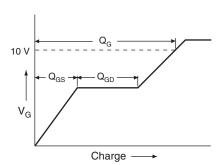


Fig. 13a - Basic Gate Charge Waveform

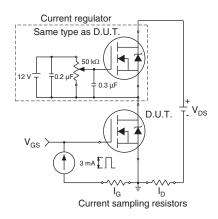
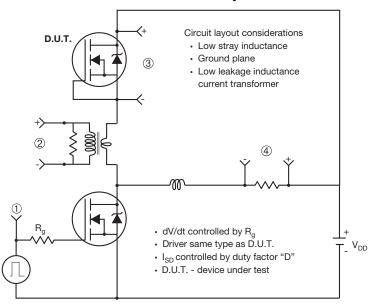


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



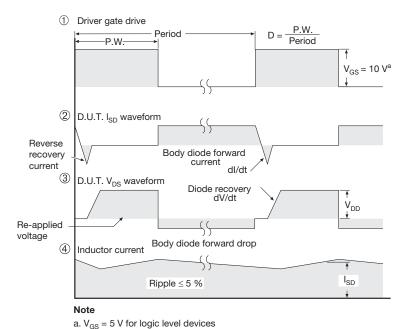
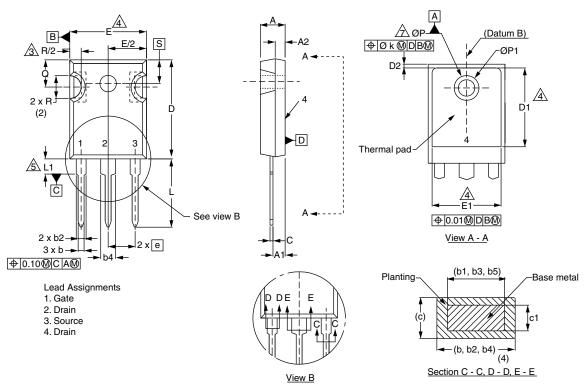


Fig. 14 - For N-Channel

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# **TO-247AC (High Voltage)**



|      | MILLIMETERS |       | INC   | HES   |
|------|-------------|-------|-------|-------|
| DIM. | MIN.        | MAX.  | MIN.  | MAX.  |
| Α    | 4.58        | 5.31  | 0.180 | 0.209 |
| A1   | 2.21        | 2.59  | 0.087 | 0.102 |
| A2   | 1.17        | 2.49  | 0.046 | 0.098 |
| b    | 0.99        | 1.40  | 0.039 | 0.055 |
| b1   | 0.99        | 1.35  | 0.039 | 0.053 |
| b2   | 1.53        | 2.39  | 0.060 | 0.094 |
| b3   | 1.65        | 2.37  | 0.065 | 0.093 |
| b4   | 2.42        | 3.43  | 0.095 | 0.135 |
| b5   | 2.59        | 3.38  | 0.102 | 0.133 |
| С    | 0.38        | 0.86  | 0.015 | 0.034 |
| c1   | 0.38        | 0.76  | 0.015 | 0.030 |
| D    | 19.71       | 20.82 | 0.776 | 0.820 |
| D1   | 13.08       | -     | 0.515 | -     |

|         | MILLIMETERS |          | INC       | HES       |  |
|---------|-------------|----------|-----------|-----------|--|
| DIM.    | MIN.        | MAX.     | MIN.      | MAX.      |  |
| D2      | 0.51        | 1.30     | 0.020     | 0.051     |  |
| E       | 15.29       | 15.87    | 0.602     | 0.625     |  |
| E1      | 13.72       | ı        | 0.540     | ı         |  |
| е       | 5.46        | BSC      | 0.215 BSC |           |  |
| Øk      | 0.2         | 254      | 0.010     |           |  |
| L       | 14.20       | 16.25    | 0.559     | 0.640     |  |
| L1      | 3.71        | 4.29     | 0.146     | 0.169     |  |
| N       | 7.62        | 7.62 BSC |           | 0.300 BSC |  |
| ØΡ      | 3.51        | 3.66     | 0.138     | 0.144     |  |
| Ø P1    | -           | 7.39     | -         | 0.291     |  |
| Q       | 5.31        | 5.69     | 0.209     | 0.224     |  |
| R       | 4.52        | 5.49     | 0.178     | 0.216     |  |
| S       | 5.51 BSC    |          | 0.217 BSC |           |  |
| 0.01200 |             |          |           |           |  |

ECN: X13-0103-Rev. D, 01-Jul-13

DWG: 5971

## **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.





## **Legal Disclaimer Notice**

Vishay

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